

Notice of References Cited	Application/Control No. 10/532,685		Applicant(s)/Patent Under Reexamination SAITOH, TAKASHI	
	Examiner TRI V. NGUYEN		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

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	U	STN search report indicating the structures of Glatkowski reference (Feb 2003).
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